

<b>Search Notes</b> 	<b>Application/Control No.</b> 10/516,808	<b>Applicant(s)/Patent under Reexamination</b> BONO ET AL.
	<b>Examiner</b> Erich A. Leeser	<b>Art Unit</b> 1624

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
updated STN structure search	8/14/2007	EL
updated PALM inventor search	8/14/2007	EL
updated EAST 514/252.13, 255.01, 255.05; 544/358, 360, 367, 372, 374, 386 with search terms, see printout	8/14/2007	EL

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
updated EAST keyword search see printout for class/subclass		8/14/2007	EL